



ELECTROMAGNETIC COMPLIANCE TEST REPORT

For

V10 body slimming equipment

Model: B-022

Brand Name:



Report No.: ENC140521GZ83E1

Date of Issue: Apr. 20, 2014

Prepared For

Guangzhou GLM Beauty Spa Equipment Factory

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Prepared By

East Notice Certification Service Co., Ltd.

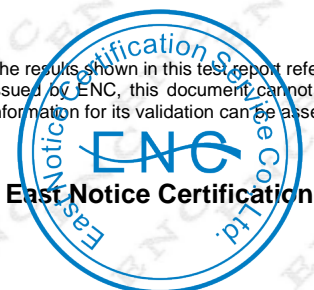
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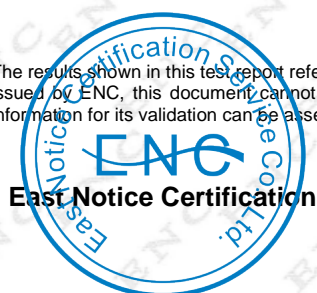
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1. VERIFICATION OF CONFORMITY

Equipment Under Test:	V10 body slimming equipment
Model Name:	B-022
Model Difference:	N/A
Brand Name:	
Applicant:	Guangzhou GLM Beauty Spa Equipment Factory 4th floor A building Huixin industrial zone, No.89 Hetai Road, Baiyun district, GuangZhou, China
Manufacturer:	Guangzhou GLM Beauty Spa Equipment Factory 4th floor A building Huixin industrial zone, No.89 Hetai Road, Baiyun district, GuangZhou, China
Type of Test:	EMC Directive 2004/108/EC for CE Marking
Technical Standards:	EN 55014-1:2006+A1:2009+A2:2011 EN 55014-2:1997+A1:2001+A2:2008 EN 61000-3-2:2006+A1:2009+A2:2009 EN 61000-3-3:2013 (IEC 61000-4-2:2008; IEC 61000-4-3:2010; IEC 61000-4-4:2012; IEC 61000-4-5:2005; IEC 61000-4-6:2013; IEC 61000-4-11:2004)
File Number:	ENC140521GZ83E1
Date of test:	Apr. 10, 2014 – Apr. 20, 2014
Deviation:	None
Condition of Test Sample:	Normal

The above equipment was tested by East Notice Certification Service Co., Ltd. for compliance with the requirements set forth in EMC Directive 2004/108/EC and the Technical Standards mentioned above. This said equipment in the configuration described in this report shows the maximum emission levels emanating from equipment and the level of the immunity endurance of the equipment are within the compliance requirements.

Should any objections to the test reports occurred, should submit it to the Company within ten days since the issuing of the report, Fail to accept.

The test results of this report relate only to the tested Sample identified in this report.

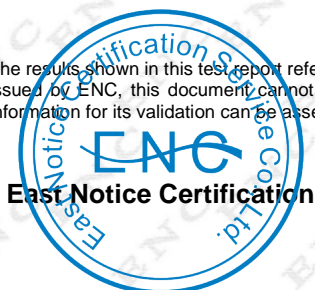
Checked By Yemig

Yemig Apr. 20, 2014

Authorized By Ray Zhou

Ray Zhou Apr. 20, 2014

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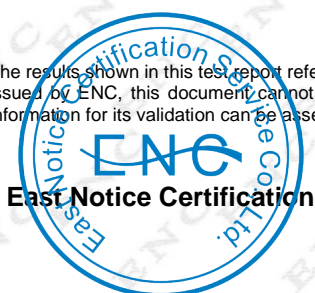


2. SYSTEM DESCRIPTION

EUT Test Procedure:

1. Connect EUT and peripheral devices if need.
2. Power on the EUT, the EUT begins to work.
3. Make sure the EUT operates normally during the test.

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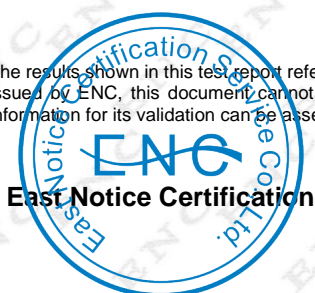
3. PRODUCT INFORMATION

Housing Type : Plastic
Rating Voltage : 220-240V~, 50Hz
Rating Power : 1000W
Protection class : I

I/O Port Information (☒Applicable ☐Not Applicable)

I/O Port of EUT			
I/O Port Type	Q'TY	Cable	Tested with
AC INPUT PORT	1	1	1

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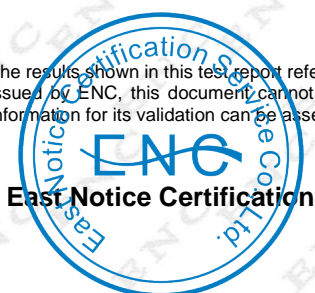
4. SUPPORT EQUIPMENT

Device Type	Manufacturer	Model Name	Serial No.	Data Cable	Power Cable
--	--	--	--	--	--

****Note:** All the above equipment/cables were placed in worse case positions to maximize emission signals during emission test.

Grounding: Grounding was in accordance with the manufacturer's requirements and conditions for the intended use.

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5. TEST FACILITY

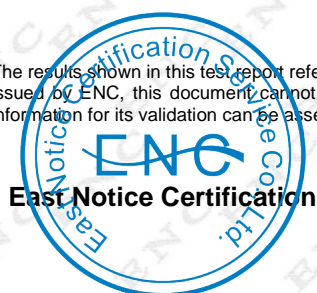
Location: 1/F, Haohui Commercial Building, Zhuji Street, Dongpu Town, Tianhe District, Guangzhou City, China

Description: There is one 3m semi-anechoic an area test sites and two line conducted labs for final test. The Open Area Test Sites and the Line Conducted labs are constructed and calibrated to meet the FCC requirements in documents ANSI C63.4 and CISPR 22/EN 55022 requirements.

Site Filing: The site description is on file with the Federal Communications Commission, 7435 Oakland Mills Road, Columbia, MD 21046.

Instrument Tolerance: All measuring equipment is in accord with ANSI C63.4 and CISPR 22 requirements that meet industry regulatory agency and accreditation agency requirement.

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6. EN 55014 LINE CONDUCTED EMISSION TEST

6.1. TEST EQUIPMENT OF CONDUCTED EMISSION TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Spectrum Analyzer	Aeroflex	2399A	N/A	03/23/2014	03/22/2015
LISN	HAMEG	HM6050-2	N/A	03/23/2014	03/22/2015

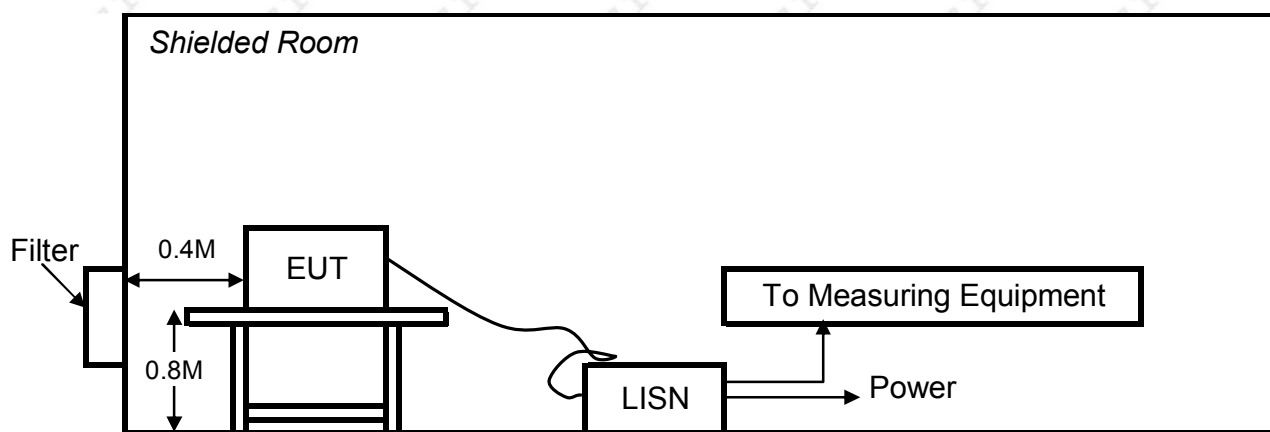
6.2. LIMITS OF LINE CONDUCTED EMISSION TEST

Frequency	Maximum RF Line Voltage	
	Q.P.(dBuV)	Average(dBuV)
150kHz-500kHz	66-56	56-46
500kHz-5MHz	56	46
5MHz-30MHz	60	50

****Note:** 1. The lower limit shall apply at the transition frequency.

2. The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz

6.3. BLOCK DIAGRAM OF TEST SETUP



A: Powered through filter

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6.4. PROCEDURE OF LINE CONDUCTED EMISSION TEST

- 1) The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. When the EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per EN55014 (see Test Facility for the dimensions of the ground plane used). When the EUT is a floor-standing equipment, it is placed on the ground plane which has a 3-12 mm non-conductive covering to insulate the EUT from the ground plane.
- 2) Support equipment, if needed, was placed as per EN55014
- 3) All I/O cables were positioned to simulate typical actual usage as per EN55014
- 4) The EUT received AC230V/50Hz power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5) All support equipments received power from a second LISN supplying power of AC 230V/50Hz, if any.
- 6) The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7) Analyzer / Receiver scanned from 150 kHz to 30 MHz for emissions in each of the test modes.
- 8) During the above scans, the emissions were maximized by cable manipulation.
- 9) A scan was taken on both power lines, Line 1 and Line 2, recording at least the six highest emissions.
- 10) Emission frequency and amplitude were recorded into a computer in which correction factors were used to calculate the emission level and compare reading to the applicable limit. If EUT emission level was less -2dB to the A.V. limit in Peak mode, then the emission signal was re-checked using Q.P and Average detector.

The test data of the worst case condition(s) was reported on the Summary Data page.

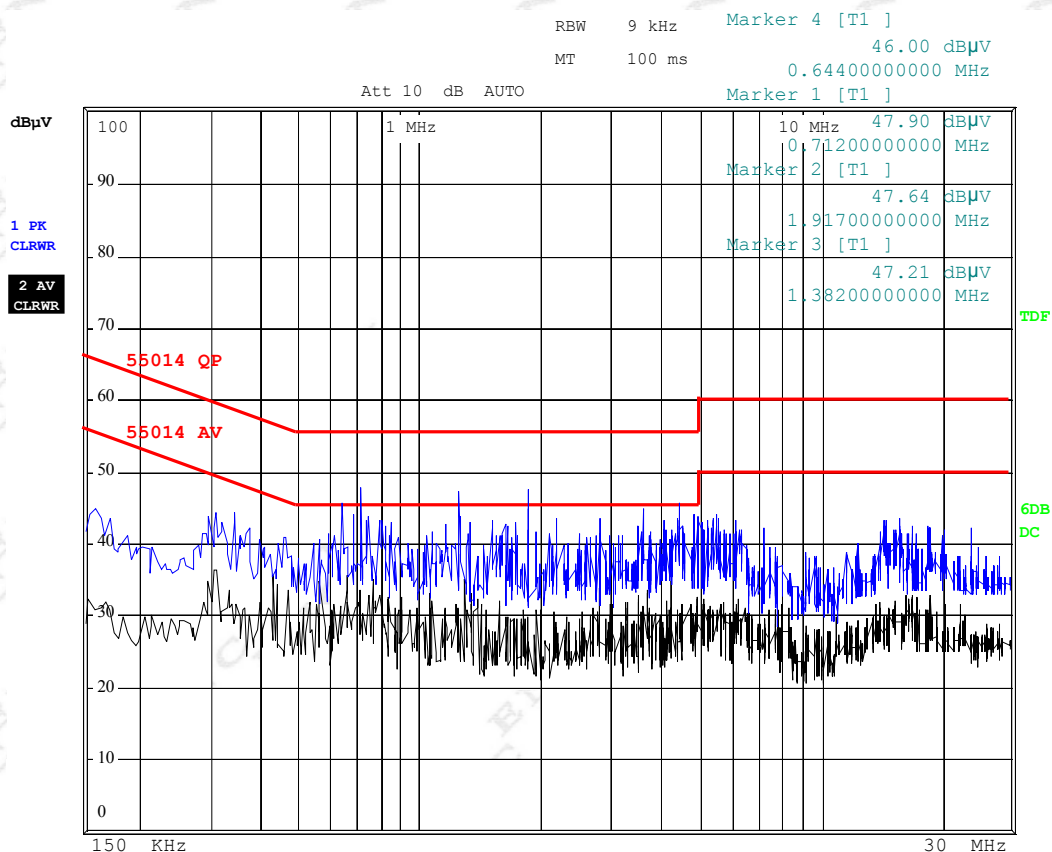
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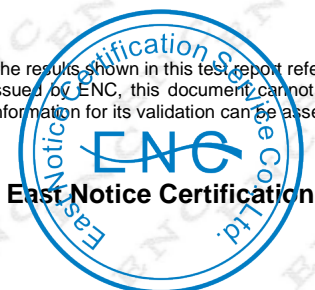
6.5. TEST RESULT OF LINE CONDUCTED EMISSION TEST

EUT : V10 body slimming equipment
M/N : B-022
Mode : Normal, L

Power : AC230V
Temperature : 25℃
Humidity : 54%



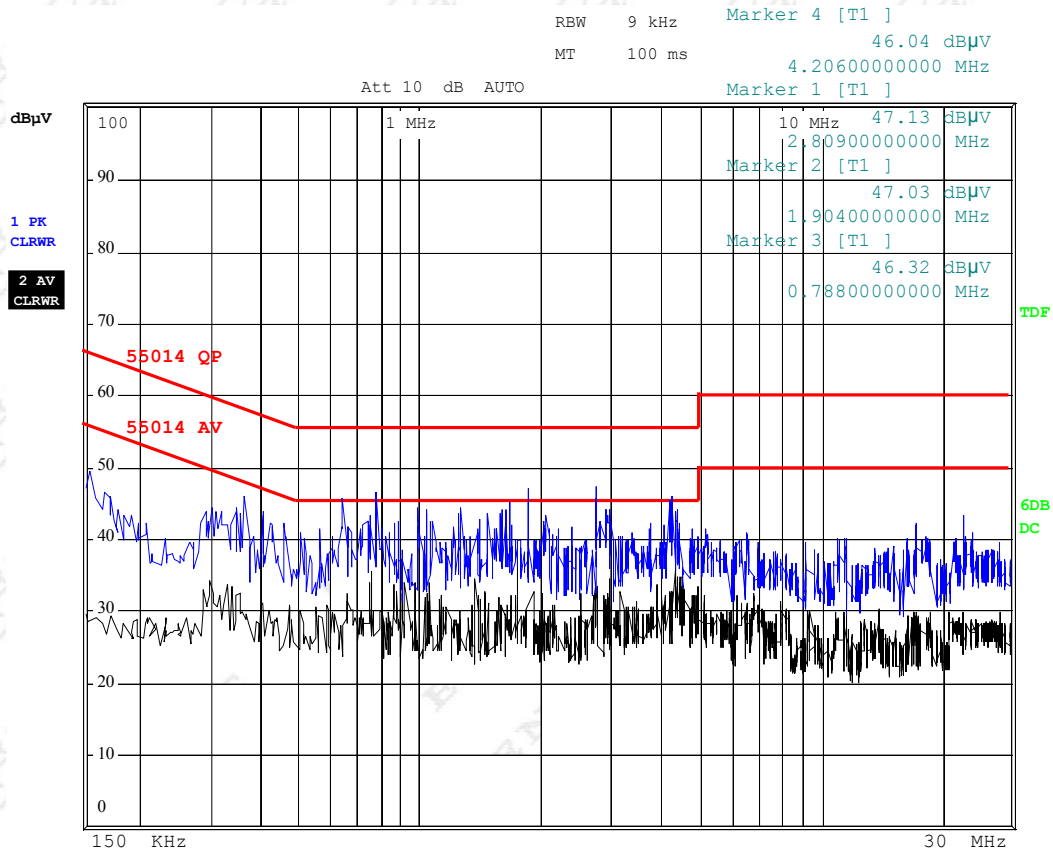
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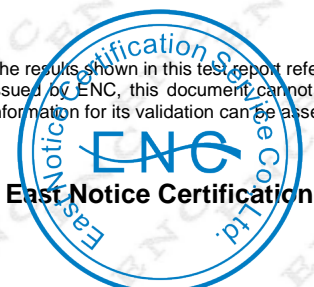


EUT : V10 body slimming equipment
M/N : B-022
Mode : Normal, N

Power : AC230V
Temperature : 25°C
Humidity : 54%



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7. EN55014 DISTURBANCE POWER EMISSION TEST

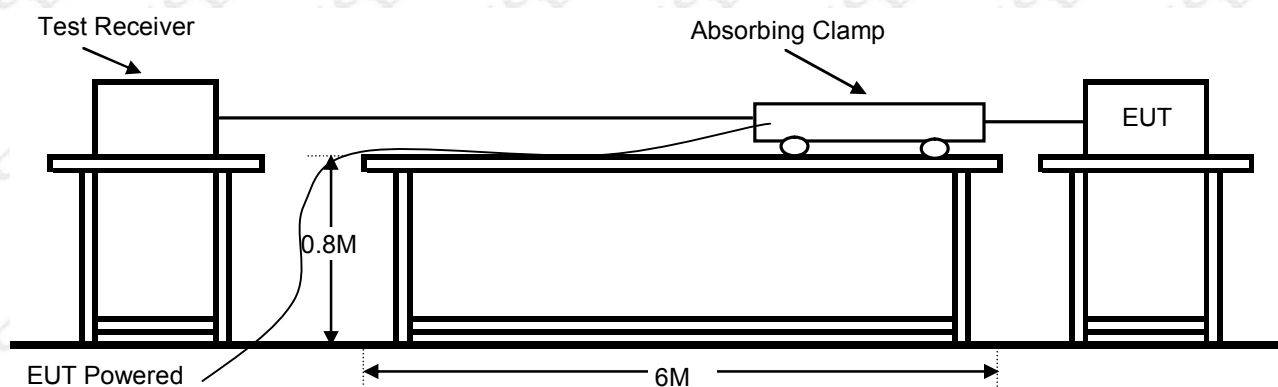
7.1. TEST EQUIPMENT OF DISTURBANCE POWER EMISSION TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Test Receiver	R&S	CISPR16	N/A	03/23/2014	03/22/2015
Absorbing Clamp	CSI	CLA-050	N/A	03/23/2014	03/22/2015
Cable	TS	TS@90	N/A	03/23/2014	03/22/2015

7.2. LIMITS OF DISTURBANCE POWER EMISSION TEST

Equipment Type	Frequency (MHz)	Limit Values dB(pW)	
		Quasi-peak	Average
Associated equipment	30-300	45-55	35-45
Increasing linearly with the frequency			

7.3. BLOCK DIAGRAM OF TEST SETUP



Note:

EUT is placed on a non-metallic table of 0.1 m of height above the floor and at least 0.8m from other metallic objects and from any person. The lead to be measured shall be stretched in a straight horizontal line for length sufficient to accommodate the absorbing clamp.

The absorbing clamp is placed around the lead to be measured, with its current transformer towards the equipment under test.

All connectors not used shall be left un-terminated. All connectors having a connected lead shall be terminated in a manner representative of use.

The absorbing clamp is applied successively to all leads whose length is 25cm or longer, unscreened or screened, which may be connected to the individual units of the equipment under test.

At each test frequency the absorbing clamp shall be moved along the lead until the maximum value is found between a position adjacent to the equipment under test and a distance of about a half wavelength from it.

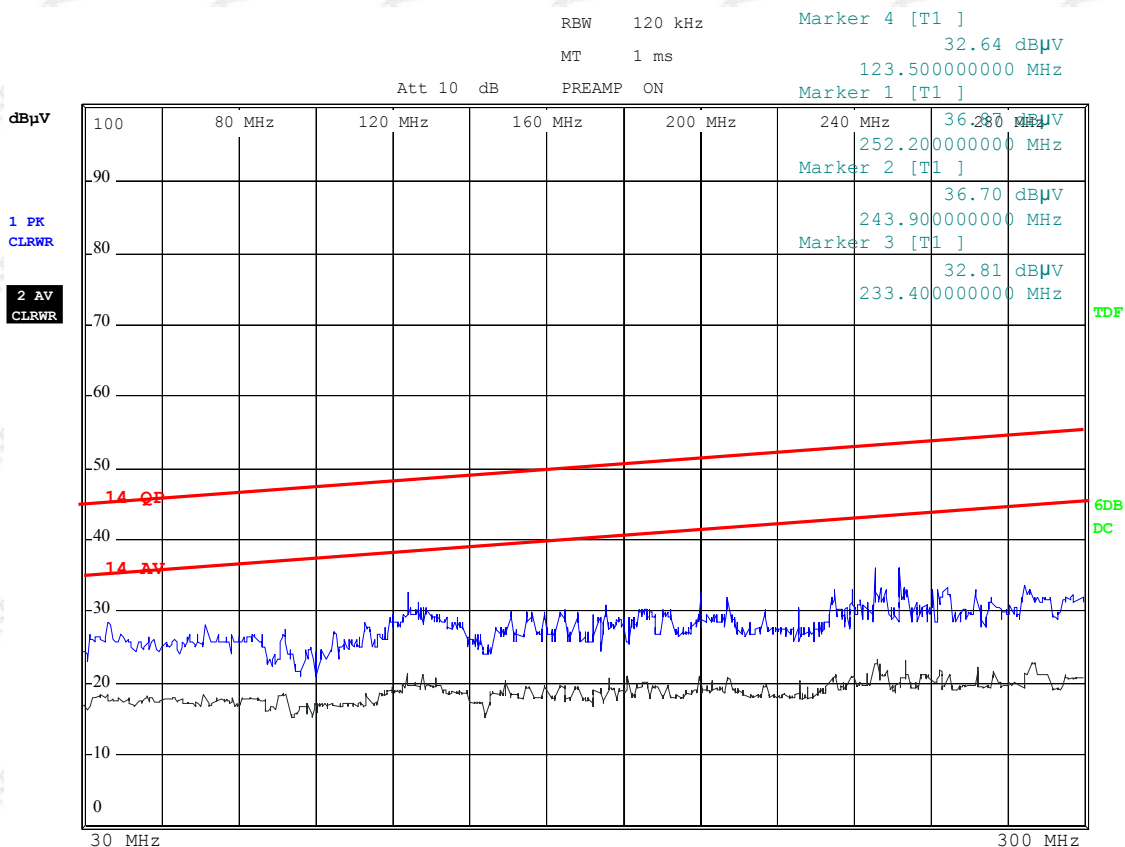
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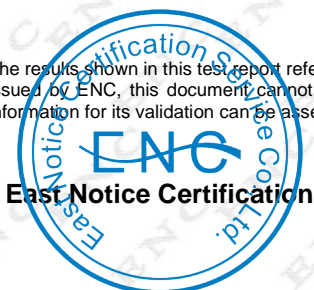
7.4. SUMMARY DATA OF DISTURBANCE POWER EMISSION TEST

EUT : V10 body slimming equipment
M/N : B-022
Mode : Normal

Power : AC230V
Temperature : 25°C
Humidity : 54%



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8. EN 61000-3-2 POWER HARMONICS TEST

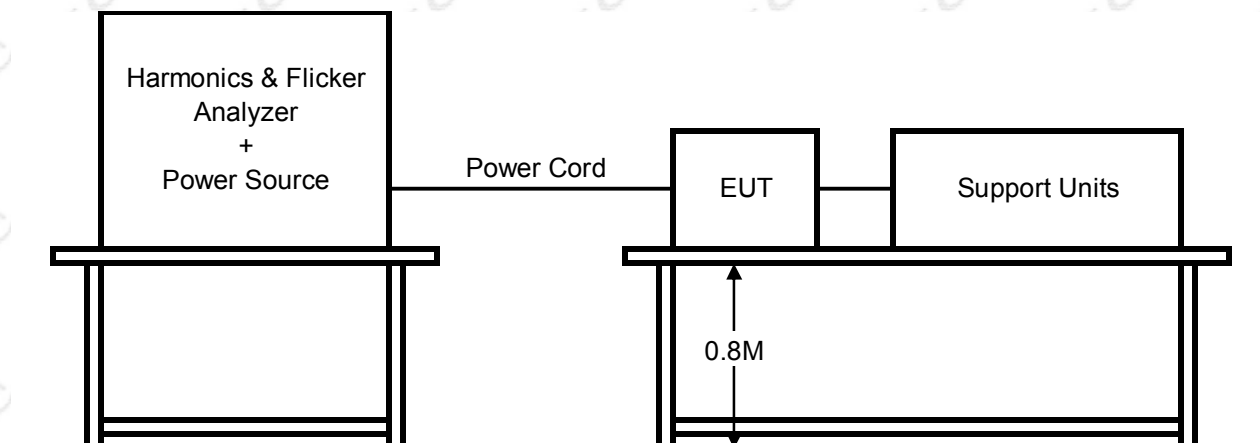
POWER HARMONICS MEASUREMENT

Port : AC mains
Basic Standard : EN 61000-3-2:2006+A1+A2
Limits : CLASS A
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

8.1. TEST EQUIPMENT OF POWER HARMONICS TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Harmonic Emission Flicker	California instruments	500LIX-400	N/A	03/23/2014	03/22/2015

8.2. BLOCK DIAGRAM OF TEST SETUP



Note:

1. The EUT was tested with the equipment configured to its rated current.
2. The measurements were carried out under steady conditions. When a piece of EUT is brought into operation or is taken out of operation, manually or automatically, harmonic currents and power are not taken into account at first 10s following the switching event. EUT shall not be in standby mode for more than 10% of any observation period.
3. Harmonics of the fundamental current were measured using a digital power meter with an analogue output and frequency analyser which was integrated in the harmonic & flicker test system.
4. For each harmonic order, measure the 1,5 s smoothed r.m.s. harmonic current in each DFT time window and calculate the arithmetic average of the measured values from the DFT time windows, over the entire observation period. Each harmonic order, all 1.5 s smoothed r.m.s. harmonic current values and the average values for the individual harmonic currents, taken over the entire test observation period shall be less than or equal to the applicable limits.

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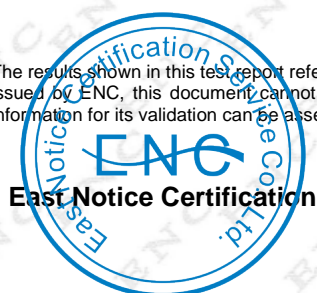
8.3. LIMITS OF HARMONIC CURRENT

Limits for Class A Equipment	
Harmonics Order n	Max. permissible harmonic current (A)
Odd harmonics	
3	2.3
5	1.14
7	0.77
9	0.40
11	0.33
13	0.21
$15 \leq n \leq 39$	$0.15 \times 15/n$
Even harmonics	
2	1.08
4	0.43
6	0.30
$8 \leq n \leq 40$	$0.23 \times 8/n$

NOTE:

- According to section 5 of EN61000-3-2: 2006, the EUT is Class A equipment.
- The above limits are for all applications having an active input power > 75W. No limits apply for equipment with an active input power up to and including 75W.

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8.4. RESULT

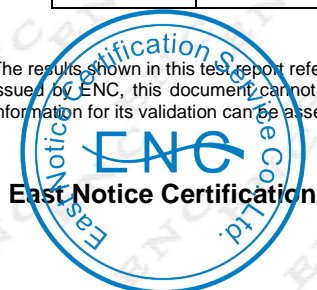
Test Specification

Test Frequency:	50Hz	Test Voltage:	230Vac
Waveform:	Sine	Test Time:	2.5min
Classification:	Class A	Test result:	PASS

Harmonic current results

Hn	Harms(max) [A]	Limit [%]	Limit[A]	Result
1	5.503			
2	0.025	2.325	1.080	PASS
3	0.698	30.367	2.300	PASS
4	0.018	4.237	0.430	PASS
5	0.370	32.498	1.140	PASS
6	0.018	6.073	0.300	PASS
7	0.243	31.550	0.770	PASS
8	0.015	6.602	0.230	PASS
9	0.200	50.106	0.400	PASS
10	0.012	6.602	0.184	PASS
11	0.088	26.686	0.330	PASS
12	0.009	5.954	0.153	PASS
13	0.079	37.597	0.210	PASS
14	0.007	5.344	0.131	PASS
15	0.070	46.563	0.150	PASS
16	0.006	5.281	0.115	PASS
17	0.055	41.410	0.132	PASS
18	0.005	4.902	0.102	PASS
19	0.024	20.588	0.118	PASS
20	0.004	4.348	0.092	PASS
21	0.036	34.057	0.107	PASS
22	0.003	3.571	0.084	PASS
23	0.039	40.283	0.098	PASS
24	0.002	2.597	0.077	PASS
25	0.030	33.741	0.090	PASS
26	0.001	1.408	0.071	PASS
27	0.015	18.293	0.083	PASS
28	0.001	1.515	0.066	PASS
29	0.012	15.573	0.078	PASS
30	0.000	0.000	0.061	PASS
31	0.015	20.799	0.073	PASS
32	0.000	0.000	0.058	PASS
33	0.012	17.863	0.068	PASS
34	0.000	0.000	0.054	PASS
35	0.009	14.235	0.064	PASS
36	0.000	0.000	0.051	PASS
37	0.006	9.956	0.061	PASS
38	0.000	0.000	0.048	PASS
39	0.003	5.172	0.058	PASS
40	0.000	0.000	0.046	PASS

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9. EN 61000-3-3 VOLTAGE FLUCTUATION / FLICKER TEST

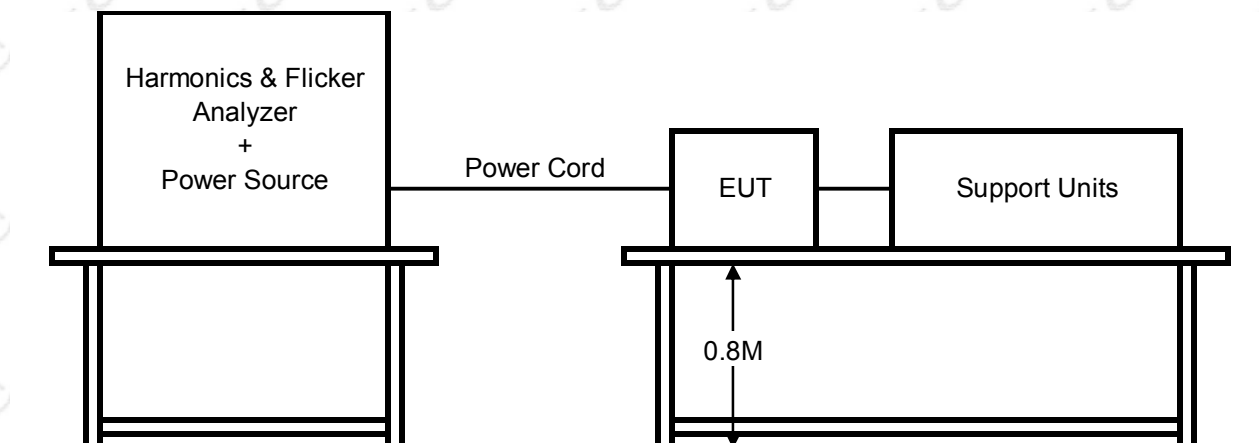
VOLTAGE FLUCTUATION/FLICKER MEASUREMENT

Port : AC mains
Basic Standard : EN 61000-3-3:2013
Limits : §5 of EN 61000-3-3
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

9.1. TEST EQUIPMENT OF VOLTAGE FLUCTUATION / FLICKER TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Harmonic Emission Flicker	California instruments	500LIX-400	N/A	03/23/2014	03/22/2015

9.2. BLOCK DIAGRAM OF TEST SETUP



- The test supply voltage (open-circuit voltage) was the rated voltage of the EUT. The test voltage was maintained within $\pm 2\%$ of the nominal value. The frequency was 50 Hz $\pm 0.5\%$.
- The voltage fluctuations and flicker were measured at the supply terminals of the EUT.
- The observation period, T_p , for the assessment of flicker values by flicker measurement, flicker simulation, or analytical method was:
 - for P_{st} , $T_p = 10$ min;
 - for P_{lt} , $T_p = 2$ h.

The observation period included that part of the whole operation cycle in which the EUT produces the most unfavourable sequence of voltage changes.

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9.3. RESULT

Flicker Test Summary per EN/IEC61000-3-3 (Run time)

EUT: V10 body slimming equipment

Tested by: Sam Liu

Test category: All parameters (European limits)

Test Margin: 100

Test date: 2014-04-15

Start time: 10:13:11

End time: 10:23:11

Test duration (min): 10

Comment: On

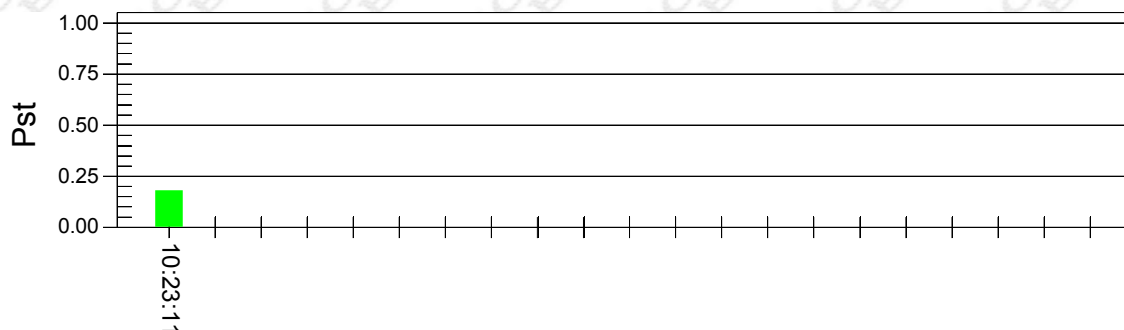
Customer: Guangzhou GLM Beauty Spa Equipment Factory

Test Result: Pass

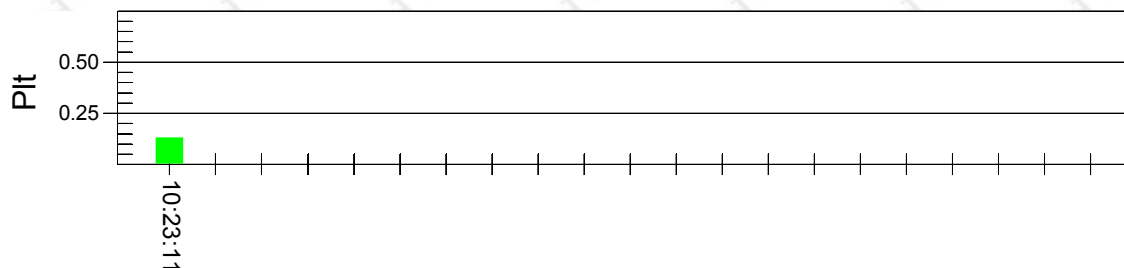
Source qualification: OK

Pst and limit line

European Limits



Plt and limit line



Parameter values recorded during the test:

Vrms at the end of test (Volt): 230.1

Highest dt(%): -0.26

Time(mS) > dt: 0.0

Highest dc (%): 0.00

Highest dmax (%): -0.16

Highest Pst (10 min. period): 0.180

Highest Plt (2 hr. period): 0.124

Test limit (%): 3.30 Pass

Test limit (mS): 500.0 Pass

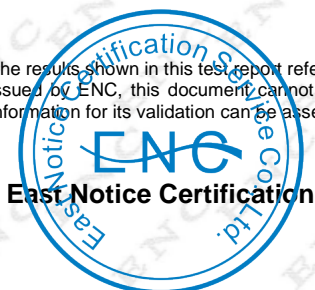
Test limit (%): 3.30 Pass

Test limit (%): 4.00 Pass

Test limit: 1.000 Pass

Test limit: 0.650 Pass

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10. IEC 61000-4-2 ESD IMMUNITY TEST

ELECTROSTATIC DISCHARGE (ESD) IMMUNITY TEST

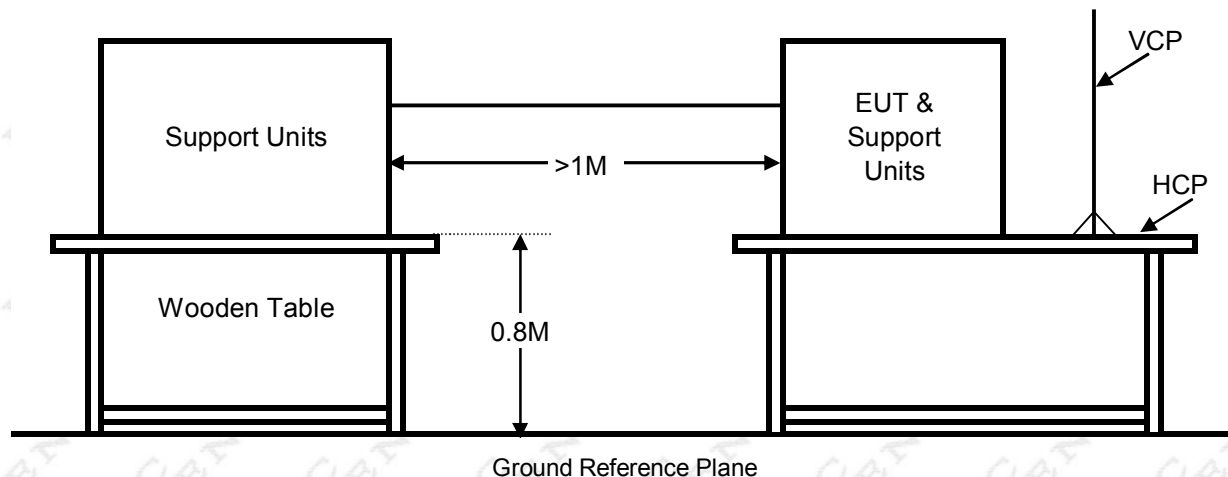
Port : Enclosure
Basic Standard : IEC 61000-4-2: 2008
Test Level : ± 8 kV (Air Discharge)
 ± 6 kV (Contact Discharge)
 ± 6 kV (Indirect Discharge)
Standard require : B
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

10.1. TEST EQUIPMENT OF ESD TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
ESD Simulator	EM-Test	EST883	N/A	03/23/2014	03/22/2015

10.2. BLOCK DIAGRAM OF TEST SETUP

(The 470 k ohm resistors are installed per standard requirement)



10.3. TEST PROCEDURE

The EUT was located 0.1 m minimum from all side of the HCP.

The support units were located 1 m minimum away from the EUT.

EUT worked with resistance load, and make sure EUT worked normally.

Activates the communication function if the EUT with such port(s).

As per the requirement of EN 55014: Contact discharge is the preferred test method. 20 discharges (10 with positive and 10 negative polarity) shall be applied on each accessible metal part of the enclosure. In case of a non-conductive enclosure, discharges shall be applied on the horizontal or vertical coupling planes as specified in IEC 61000-4-2.

Air discharges shall be used where contact discharges cannot be applied.

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The following test condition was followed during the tests.

Note: As per the A2 to IEC 61000-4-2, a bleed resistor cable is connected between the EUT and HCP during the test.

The electrostatic discharges were applied as follows:

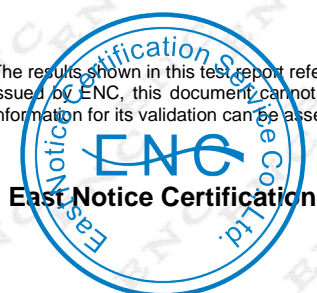
Amount of Discharges	Voltage	Coupling	Result (Pass/Fail)
Mini 20 /Point	±2kV; ±4kV	Contact Discharge	Pass
Mini 10 /Point	±2kV; ±4kV	Indirect Discharge HCP (Front)	Pass
Mini 10 /Point	±2kV; ±4kV	Indirect Discharge VCP (Left)	Pass
Mini 10 /Point	±2kV; ±4kV	Indirect Discharge VCP (Back)	Pass
Mini 10 /Point	±2kV; ±4kV	Indirect Discharge VCP (Right)	Pass
Mini 10 /Point	±2kV; ±4kV;±8kV;	Air Discharge	Pass

10.4. PERFORMANCE & RESULT

- ☐ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.
- ☒ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.
- ☐ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

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11. IEC 61000-4-3 TEST

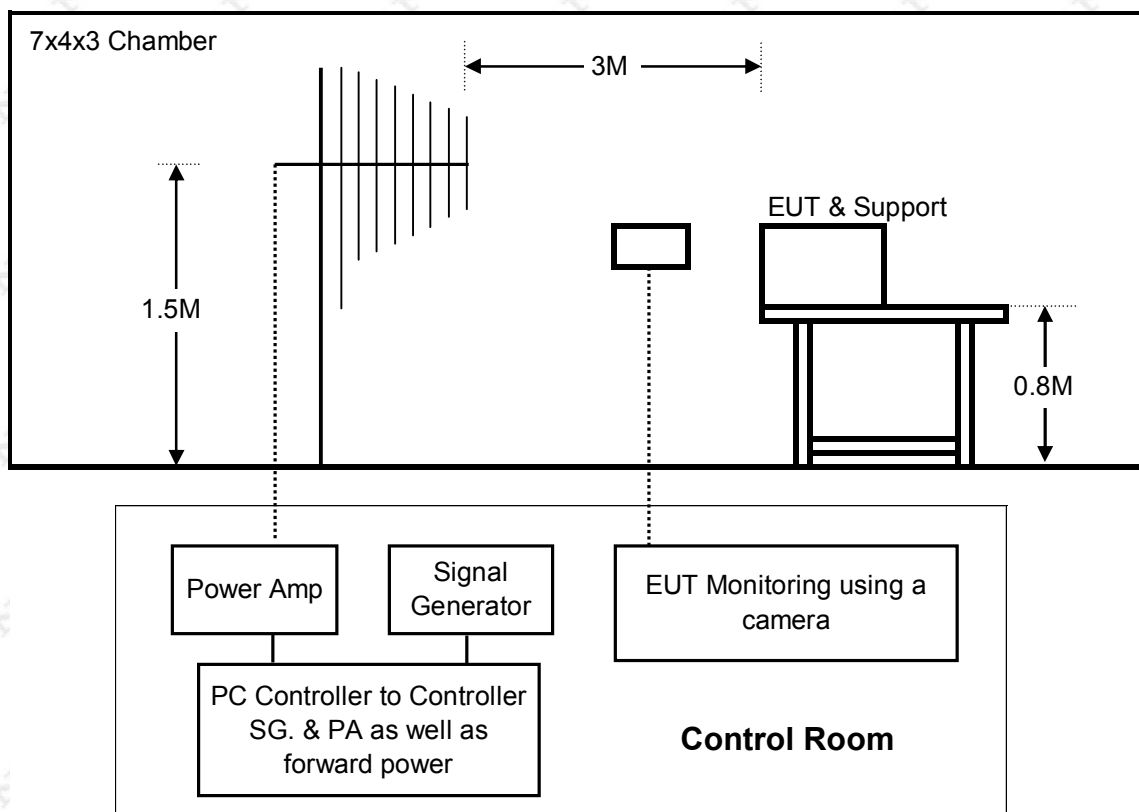
RADIATED ELECTROMAGNETIC FIELD IMMUNITY TEST

Port : Enclosure
Basic Standard : IEC 61000-4-3:2010
Test Level : 3V/m with 80% AM. 1kHz Modulation.
Standard require : A
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

11.1. TEST EQUIPMENT

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Signal Generator	IFA	2023B	N/A	03/23/2014	03/22/2015
Power Amplifier	AR	150W1000	N/A	03/23/2014	03/22/2015
Power Antenna	AR	25S1G4A	N/A	03/23/2014	03/22/2015

11.2. BLOCK DIAGRAM OF TEST SETUP



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11.3. TEST PROCEDURE

The EUT was located at the edge of supporting table keep 3 meter away from transmitting antenna, it just the calibrated square area of field uniformity. The support units were located outside of the uniformity area, but the cable(s) connected with EUT were exposed to the calibrated field as per IEC 61000-4-3.

EUT worked with resistance load, and make sure EUT worked normally.

Setting the testing parameters of RS test software per IEC 61000-4-3.

Performing the test at each side of with specified level (3V/m) at 1% steps and test frequency from 80MHz to 1000MHz and 1400MHz to 2700MHz.

Recording the test result in following table.

It is not necessary to perform test as per annex A of EN 55014 if the EUT doesn't belong to TTE product.

IEC 61000-4-3 Final test conditions:

Test level : 3V/m

Steps : 1 % of fundamental

Dwell Time : 1 sec

Range (MHz)	Field	Modulation	Polarity	Position	Result (Pass/Fail)
80-1000	3V/m	AM	H	Front	Pass
80-1000	3V/m	AM	H	Left	Pass
80-1000	3V/m	AM	H	Back	Pass
80-1000	3V/m	AM	H	Right	Pass
80-1000	3V/m	AM	V	Front	Pass
80-1000	3V/m	AM	V	Left	Pass
80-1000	3V/m	AM	V	Back	Pass
80-1000	3V/m	AM	V	Right	Pass

11.4. PERFORMANCE & RESULT

☒ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

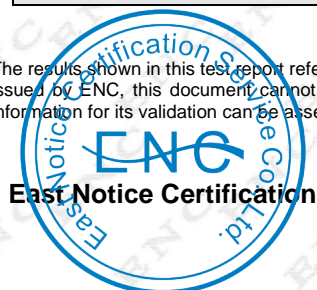
☐ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**

☐ **FAIL**

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12. IEC 61000-4-4 TEST

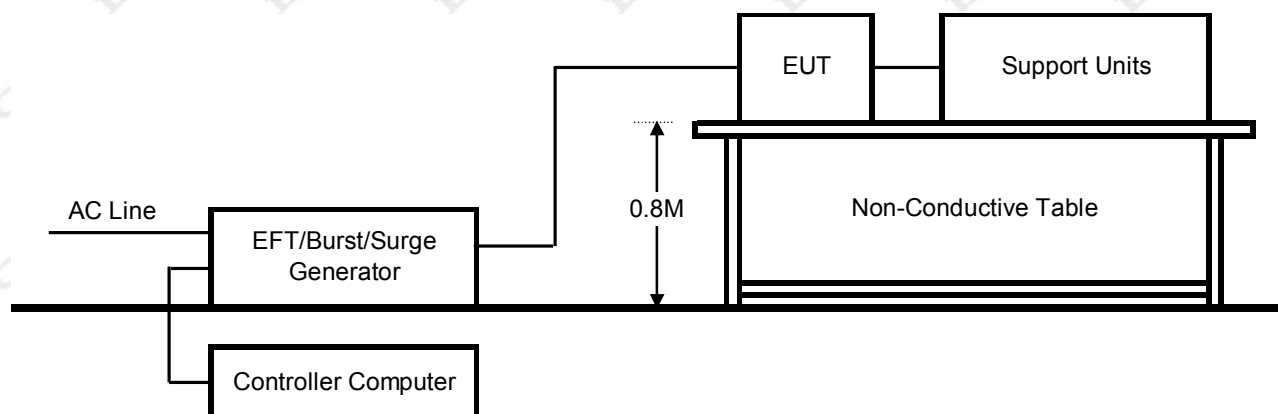
ELECTRICAL FAST TRANSIENTS/BURST IMMUNITY TEST

Port : On Power Supply Lines
Basic Standard : IEC 61000-4-4:2012
Test Level : +/- 1kV for Power Supply Lines
Standard require : B
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

12.1. TEST EQUIPMENT

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Compact Generator	EM-Test	UCS500M	N/A	03/23/2014	03/22/2015
Capacitive Clamp	EM-Test	HY21-EFTC	N/A	03/23/2014	03/22/2015
CDN for Telecom Port	EM-Test	CNV504S1	N/A	03/23/2014	03/22/2015

12.2. BLOCK DIAGRAM OF TEST SETUP



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12.3. TEST PROCEDURE

The EUT and support units were located on a wooden table 0.8m away from ground reference plane.

A 1.0 meter long power cord was attached to EUT during the test.

The length of communication cable between communication port and clamp was keeping within 1 meter.

EUT worked with resistance load, and make sure EUT worked normally.

Related peripherals work during the test.

Recording the test result as shown in following table.

Test conditions:

Impulse Frequency: 5 kHz

Tr/Th: 5/50ns

Burst Duration: 15ms

Burst Period: 300ms

Inject Line	Voltage kV	Inject Method	Result (Pass/Fail)
L+N	+ /- 1	Direct	Pass

12.4. PERFORMANCE & RESULT

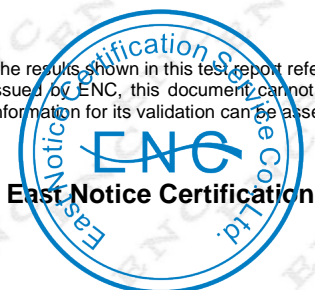
☐ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☒ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**
☐ **FAIL**

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13. IEC 61000-4-5 SURGE IMMUNITY TEST

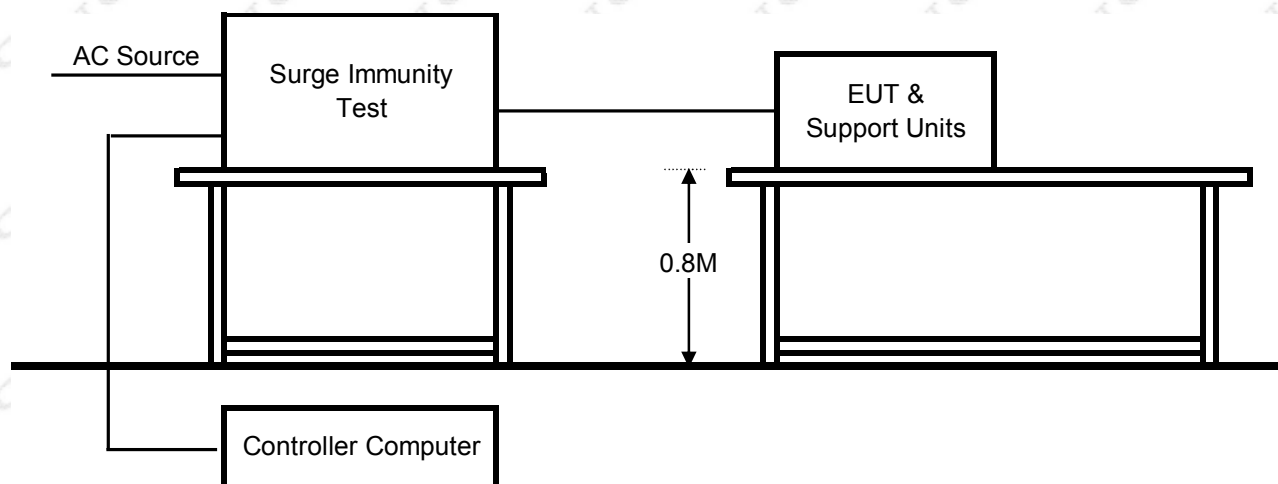
SURGE IMMUNITY TEST

Port : On Power Supply Lines
Basic Standard : IEC 61000-4-5:2005
Requirements : +/- 1kV (Line to Line)
 : +/- 2kV (Line to Ground)
Standard require : B
Tester : Sam Liu
Temperature : 25°C
Humidity : 54%

13.1. TEST EQUIPMENT OF SURGE TEST

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Compact Generator	EM-Test	UCS500M	N/A	03/23/2014	03/22/2015
Capacitive Clamp	EM-Test	HY21-EFTC	N/A	03/23/2014	03/22/2015
CDN for Telecom Port	EM-Test	CNV504S1	N/A	03/23/2014	03/22/2015

13.2. BLOCK DIAGRAM OF TEST SETUP



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13.3. TEST PROCEDURE

The EUT and support units were located on a wooden table 0.8 m away from ground floor.

EUT worked with resistance load, and make sure EUT worked normally.

Recording the test result as shown in following table.

Test conditions:

Voltage Waveform : 1.2/50 us
Current Waveform : 8/20 us
Polarity : Positive/Negative
Phase angle : 0°, 90°, 270°
Number of Test : 5

Coupling Line	Voltage (kV)	Polarity	Coupling Method	Result (Pass/Fail)
L1-L2	1	Positive	Capacitive	Pass
L1-L2	1	Negative	Capacitive	Pass
L1-PE	2	Positive	Capacitive	Pass
L1-PE	2	Negative	Capacitive	Pass
L2-PE	2	Positive	Capacitive	Pass
L2-PE	2	Negative	Capacitive	Pass

13.4. PERFORMANCE & RESULT

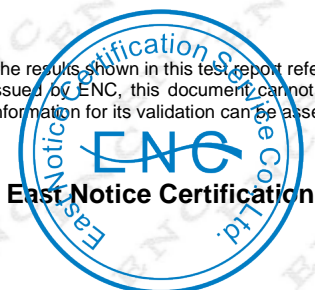
☐ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☒ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

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14. IEC 61000-4-6 TEST

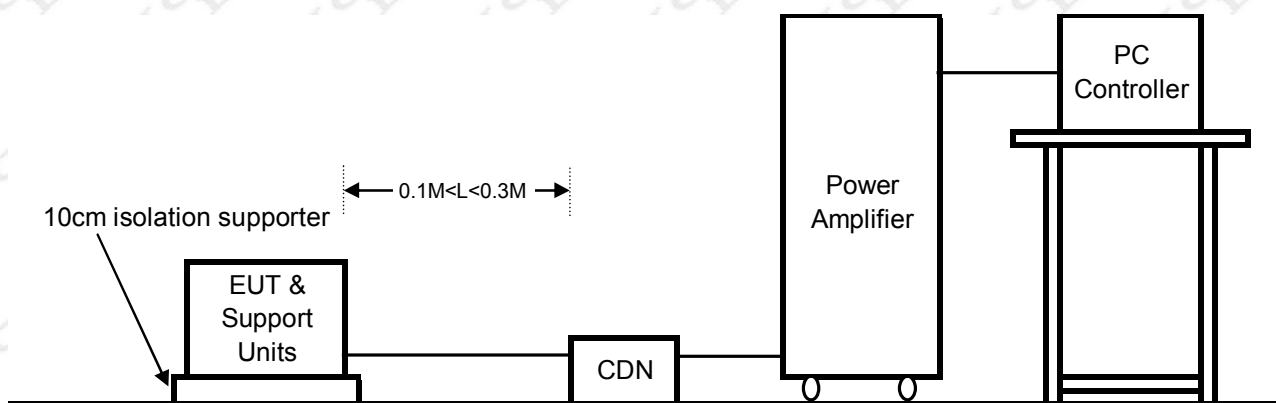
IEC 61000-4-6 IMMUNITY TO CONDUCTED DISTURBANCES, INDUCED BY RADIO-FREQUENCY FIELD

Port	: Power Supply Lines
Basic Standard	: IEC 61000-4-6:2013
Requirements	: 3V with 80% AM. 1 kHz Modulation
Standard require	: A
Tester	: Sam Liu
Temperature	: 25°C
Humidity	: 54%

14.1. TEST EQUIPMENT

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Power Amplifier	AR	150W1000	N/A	03/23/2014	03/22/2015
CDN	EM-Test	CNV504S1	N/A	03/23/2014	03/22/2015
Direction Coupler	EM-Test	DC2600N	N/A	03/23/2014	03/22/2015
EM-Clamp	EM-Test	EM101	N/A	03/23/2014	03/22/2015
Calibration	EM-Test	CAM2/M3	N/A	03/23/2014	03/22/2015
Attenuator	EM-Test	ATT6/75	N/A	03/23/2014	03/22/2015
Power Sensor	AR	PH2000	N/A	03/23/2014	03/22/2015
Power Meter	AR	PM2002	N/A	03/23/2014	03/22/2015
Signal Generator	IFA	2023A	N/A	03/23/2014	03/22/2015

14.2. BLOCK DIAGRAM OF TEST SETUP



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14.3. TEST PROCEDURE

The EUT and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.

EUT worked with resistance load, and make sure EUT worked normally.

Related peripherals work during the test.

Setting the testing parameters of CS test software per IEC 61000-4-6.

Recording the test result in following table.

Test conditions:

Frequency Range: 0.15MHz-230MHz

Frequency Step: 1% of fundamental

Dwell Time: 1 sec

Range (MHz)	Strength	Modulation	Result (Pass/Fail)
0.15-230	3V	AM	Pass

14.4. PERFORMANCE & RESULT

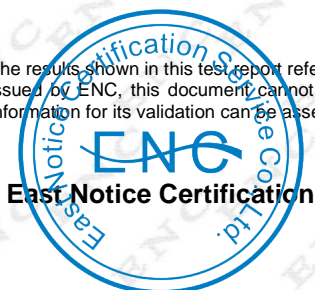
☒ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☐ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☐ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS**☐ **FAIL**

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15. IEC 61000-4-11 TEST

VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS IMMUNITY TEST

Port	: Power Supply Lines
Basic Standard	: IEC 61000-4-11:2004
Requirements	: 0, 45, 90, 135, 180, 225, 270, 315 degrees
Standard require	: Min. 10 sec.
Test Interval:	: Sam Liu
Temperature	: 25°C
Humidity	: 54%

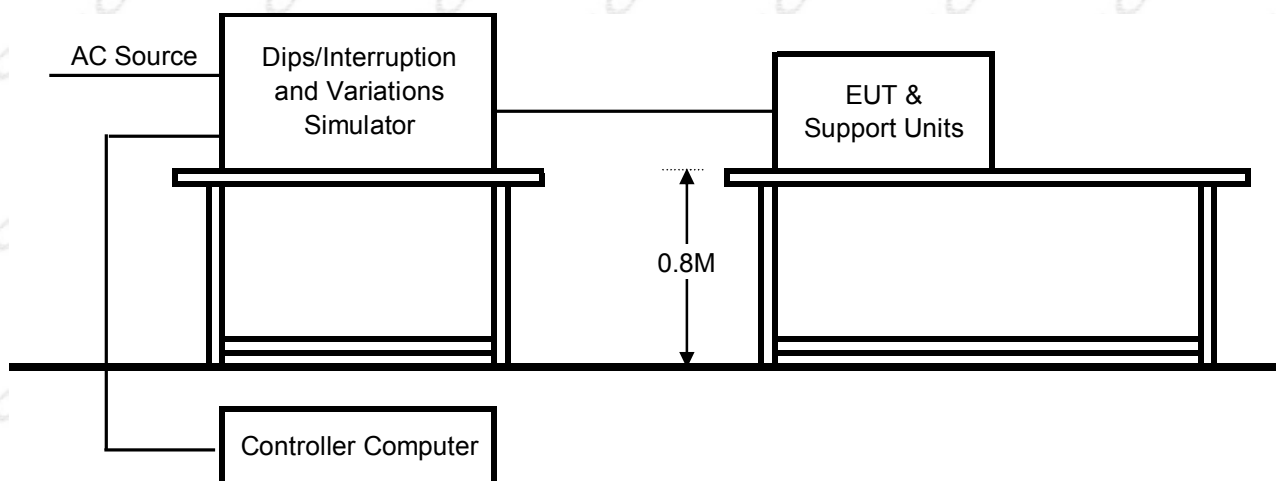
Voltage Dips	Test Level	Reduction	Duration	Performance
	% U _T	(%)	(periods)	Criteria
	40	60	10	C
	70	30	25	C

Voltage Interruptions	Test Level	Reduction	Duration	Performance
	% U _T	(%)	(periods)	Criteria
	0	100	0.5	C

15.1. TEST EQUIPMENT

Description	Manufacturer	Model	Identifier	Cal. Date	Cal. Due
Compact Generator	EM-Test	UCS500M	N/A	03/23/2014	03/22/2015
Capacitive Clamp	EM-Test	HY21-EFTC	N/A	03/23/2014	03/22/2015
CDN for Telecom Port	EM-Test	CNV504S1	N/A	03/23/2014	03/22/2015

15.2. BLOCK DIAGRAM OF TEST SETUP



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15.3. TEST PROCEDURE

The EUT and support units were located on a wooden table, 0.8 m away from ground floor. EUT worked with resistance load, and make sure EUT worked normally.

Setting the parameter of tests and then perform the test software of test simulator.

Conditions changes to occur at 0 degree crossover point of the voltage waveform.

Recording the test result in test record form.

Test conditions:

The duration with a sequence of three dips/interruptions with interval of 10 s minimum
(Between each test event)

Voltage Dips:

Test Level % U_T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
40	60	10	Normal	C
70	30	25	Normal	C

Voltage Interruptions:

Test Level % U_T	Reduction (%)	Duration (periods)	Observation	Meet Performance Criteria
0	100	0.5	Normal	C

15.4. PERFORMANCE

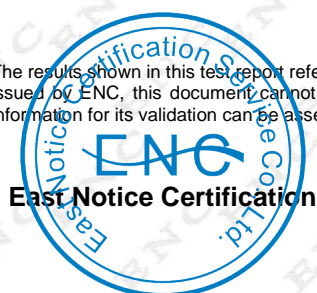
☐ Criteria A: The apparatus continues to operate as intended. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance.

☐ Criteria B: The apparatus continues to operate as intended after the test. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. In some cases the performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is however allowed.

☒ Criteria C: Temporary loss of function is allowed, provided the functions self recoverable or can be restored by the operation of controls.

☒ **PASS** ☐ **FAIL**

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APPENDIX 1

PHOTOGRAPHS OF TEST SETUP

CONDUCTED EMISSION TEST SETUP



EFT IMMUNITY / SURGE IMMUNITY / VOLTAGE DIPS TEST SETUP

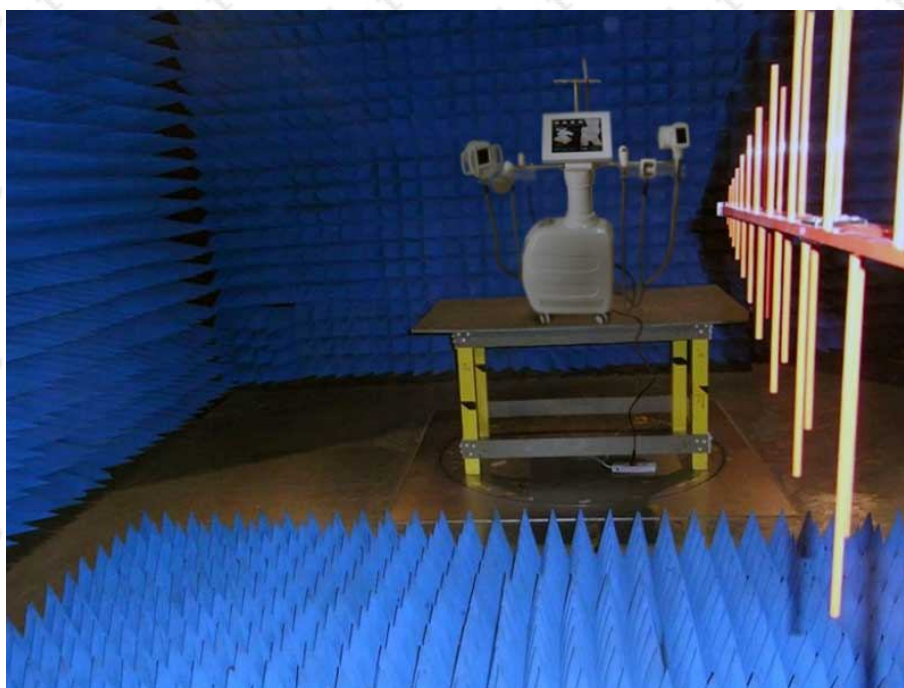


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ELECTROSTATIC DISCHARGE TEST SETUP



RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST SETUP



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APPENDIX 2 PHOTOGRAPHS OF EUT

Front View of EUT



Back View of EUT



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Right View of EUT

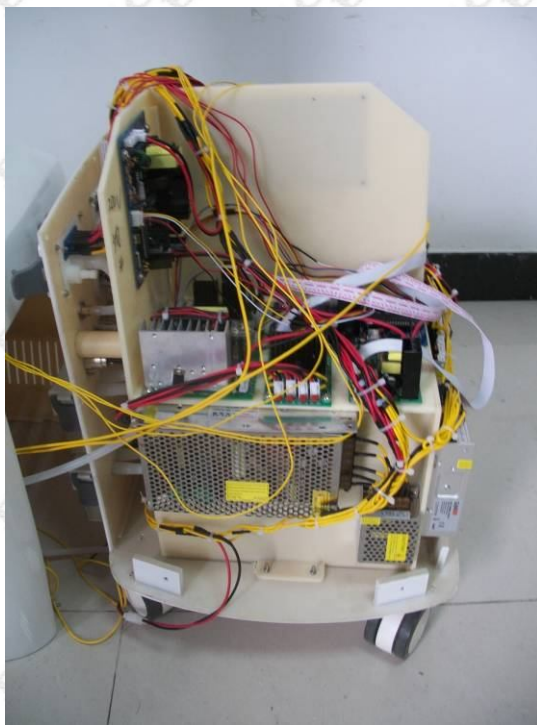


Left View of EUT

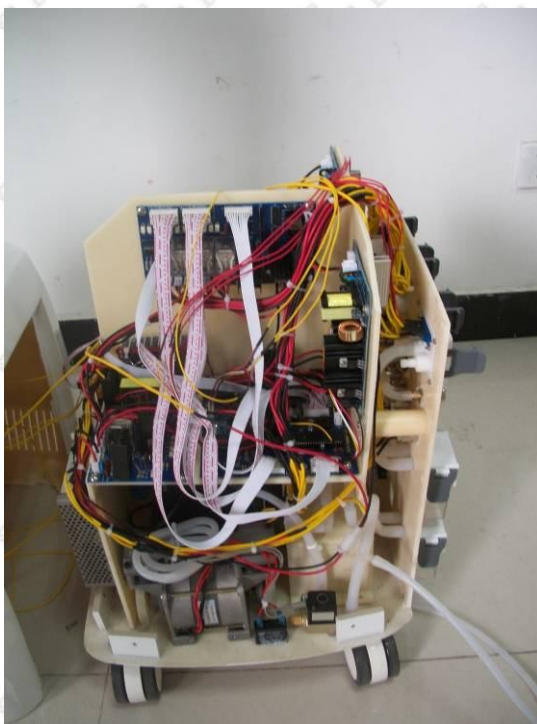


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Internal View of EUT



Internal View of EUT



----END OF REPORT----

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